



PRODUCT DATA SHEET



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Datasheet

ources Samples

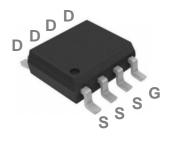
Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.

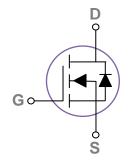


General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

SOP8 Pin Configuration





BVDSS	RDSON	ID
30V	18m Ω	9A

Features

- $30V,9A, RDS(ON) = 18m\Omega @VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _G s	Gate-Source Voltage	±20	V
I_	Drain Current – Continuous (T _A =25°C)	9	А
ID	Drain Current – Continuous (T _A =70°C)	7	А
I _{DM}	Drain Current – Pulsed ¹	36	А
EAS	Single Pulse Avalanche Energy ²	32	mJ
IAS	Single Pulse Avalanched Current ²	8	А
D	Power Dissipation (T _A =25°C)	2.5	W
P_D	Power Dissipation – Derate above 25°C	0.02	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		50	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions		Тур.	Max.	Unit
BV _{DSS}	BV _{DSS} Drain-Source Breakdown Voltage V _{GS} =0V , I _D =250μA		30			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.04		V/°C
	Drain Source Leakage Current	V _{DS} =30V , V _{GS} =0V , T _J =25°C			1	μΑ
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =125°C	10	μΑ		
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA

On Characteristics

R _{DS(ON)} Static Drai	Static Drain-Source On-Resistance ³	V _{GS} =10V , I _D =8A		16	18	mΩ
	Static Drain-Source On-Resistance	V _{GS} =4.5V , I _D =5A		23	28	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250μA		1.6	2	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			-4		mV/°C
gfs	Forward Transconductance	V_{DS} =10V , I_{D} =5A		4		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{3,4}			4.1	6	
Q _{gs}	Gate-Source Charge ^{3, 4}	V _{DS} =15V , V _{GS} =4.5V , I _D =8A		1	1.4	nC
Q_gd	Gate-Drain Charge ^{3, 4}			2.1	4	
T _{d(on)}	Turn-On Delay Time ^{3, 4}			2.8	5	
Tr	Rise Time ^{3, 4}	V_{DD} =15 V , V_{GS} =10 V , R_{G} =6 Ω		7.2	14	20
$T_{d(off)}$	Turn-Off Delay Time ^{3, 4}	I _D =1A		15.8	30	ns
Tf	Fall Time ^{3, 4}			4.6	9	
Ciss	Input Capacitance			345	500	
Coss	Output Capacitance V _{DS} =25V , V _{GS} =0V , F=1MHz			55	80	pF
Crss	Reverse Transfer Capacitance			32	45	
Rg	Gate resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz		3.2	6.4	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Symbol Parameter Conditions		Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V- V- OV Force Current			9	Α
I _{SM}	Pulsed Source Current ³	V _G =V _D =0V , Force Current			36	Α
V _{SD}	Diode Forward Voltage ³	V _G s=0V . I _S =1A . T _J =25°C			1	V

Note:

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. V_{DD} =25V, V_{GS} =10V,L=1mH, I_{AS} =8A., R_{G} =25 Ω ,Starting T_{J} =25 $^{\circ}$ C.
- 3. The data tested by pulsed , pulse width \leq 300µs , duty cycle \leq 2%.
- 4. Essentially independent of operating temperature.



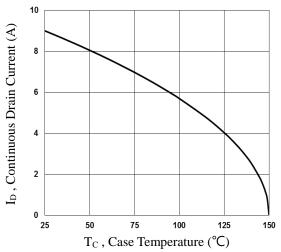


Fig.1 Continuous Drain Current vs. Tc

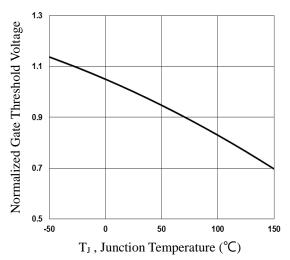


Fig.3 Normalized V_{th} vs. T_J

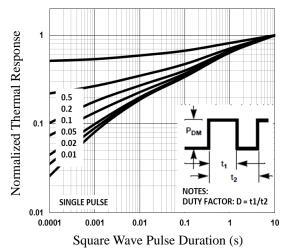


Fig.5 Normalized Transient Response

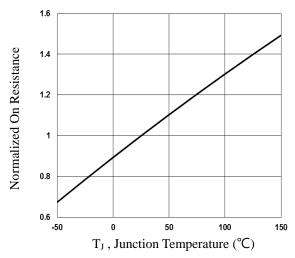


Fig.2 Normalized RDSON vs. TJ

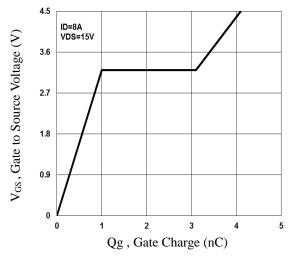


Fig.4 Gate Charge Waveform

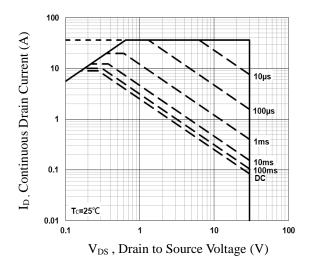


Fig.6 Maximum Safe Operation Area



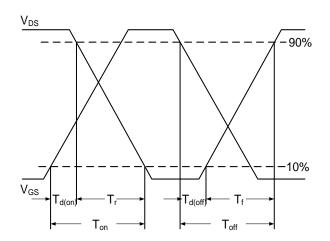


Fig.7 Switching Time Waveform

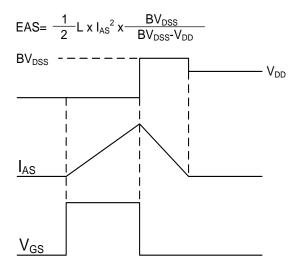
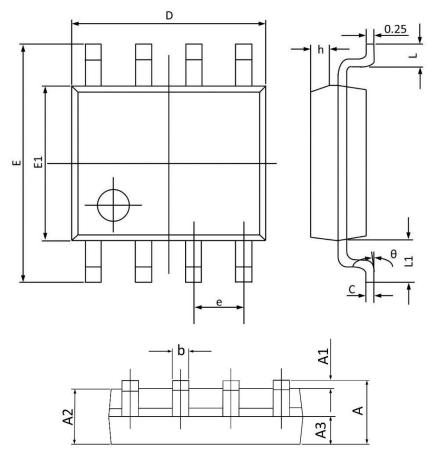


Fig.8 EAS Waveform



SOP8 PACKAGE INFORMATION



Symbol	Dimensions	In Millimeters	Dimensior	ns In Inches	
Symbol	Min	Max	Min	Max	
Α	1.350	1.800	0.053	0.069	
A1	0.050	0.250	0.002	0.010	
A2	1.250	1.650	0.049	0.065	
A3	0.500	0.700	0.020	0.028	
b	0.300	0.510	0.012	0.020	
С	0.150	0.260	0.006	0.010	
D	4.700	5.100	0.185	0.201	
E	5.800	6.200	0.228	0.244	
E1	3.700	4.100	0.146	0.161	
е	1.270	(BSC)	0.050(BSC)		
h	0.250	0.500	0.010	0.020	
L	0.400	1.000	0.016	0.039	
L1	1.050(BSC)		0.041(BSC)		
θ	0°	8°	0°	8°	



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